TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VCXH16652FT

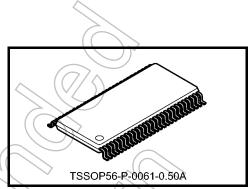
Low-Voltage 16-Bit Bus Transceiver/Register with Bushold

The TC74VCXH16652FT is a high-performance CMOS 16-bit bus transceiver/register. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

This device is bus transceiver with 3-state outputs, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the internal registers.

The A, B data inputs include active bushold circuitry, eliminating the need for external pull-up resistors to hold unused or floating data inputs at a valid logic level.

All inputs are equipped with protection circuits against static discharge.



Weight: 0.25 g (typ.)

Features (Note)

- Low-voltage operation: V_{CC} = 1.8 to 3.6 V
- Bushold on data inputs eliminating the need for external pull-up/pull-down resistors
- High-speed operation : $t_{pd} = 2.9 \text{ ns (max)} (V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$

 $t_{pd} = 3.5 \text{ ns (max) (V}_{CC} = 2.3 \text{ to } 2.7 \text{ V}$

 $: t_{pd} = 7.0 \text{ ns (max)} (V_{CC} = 1.8 \text{ V})$

- 3.6-V tolerant control inputs
- Output current: I_{OH}/I_{OL} = ±24 mA (min) (V_{CC} = 3.0 V)

 $: I_{OH}/I_{OL} = \pm 18 \text{ mA (min) (V}_{CC} = 2.3 \text{ V)}$

 $: I_{OH}/I_{OL} = \pm 6 \text{ mA (min)} (V_{CC} = 1.8 \text{ V})$

- Latch-up performance: -300 mA
- ESD performance: Machine model $\geq \pm 200 \text{ V}$

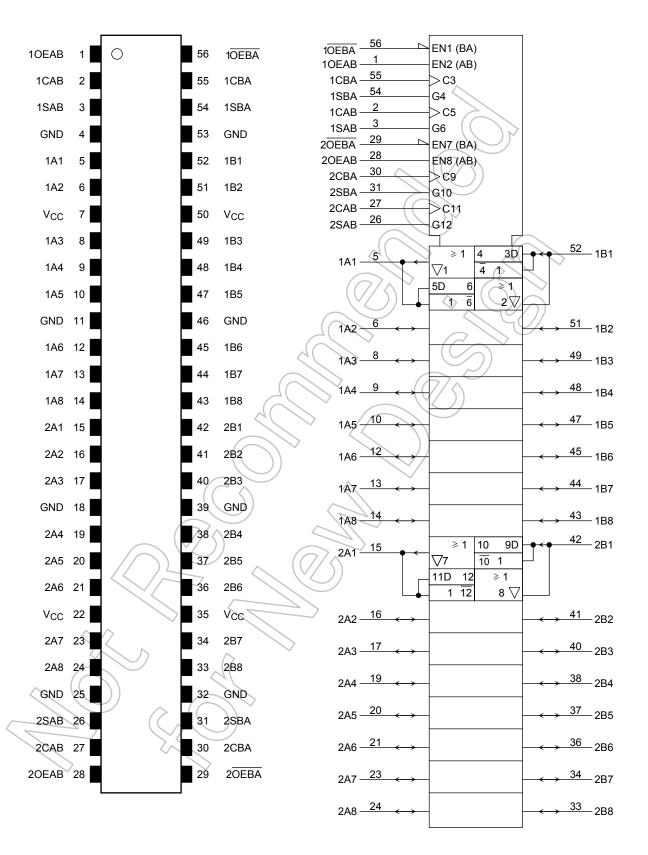
Human body model ≥ ±2000 V

Package: TSSOP

Note: Do not apply a signal to any bus pins when it is in the output mode. Damage may result.

Pin Assignment (top view)

IEC Logic Symbol



Truth Table

Control Inputs			Ві	us	Function			
OEAB	OEBA	CAB	CBA	SAB	SBA	Α	В	i diletion
		X*	X*	Х	Х	Input	Input	The output functions of A and B Busses are
L	Н					Z	Z	disabled.
_				Х	Х	Х	Х	Both A and B Busses are used as inputs to the internal flip-flops. Data on the Bus will be stored on the rising edge of the Clock.
						Input	Output	
		X*	X*	L	X	L	L <	The data on the A bus are displayed on the B bus.
						Н	Н	
		$ \uparrow $	X*	L	Х	L	L	The data on the A bus are displayed on the B Bus, and are stored into the A storage
Н	Н	7	Λ	_		Н	H	flip-flops on the rising edge of CAB.
		X*	X*	Н	Х	X	Qn	The data in the A storage flop-flops are displayed on the B/Bus.
		_				L ((//L\)	The data on the A Bus are stored into the A storage flip-flops on the rising edge of CAB,
		7	X*	н	H X)#	and the stored data propagate directly onto the B Bus.
						Output	Input	
		X*	X*	X	L		L	The data on the B Bus are displayed on the A bus.
						Ħ	Н	$(\langle // $
		X*	_	Х	4	Ş L		The data on the B Bus are displayed on the A Bus, and are stored into the B storage
L	L		7			H	Н	flip-flops on the rising edge of CBA.
		X*	X*	x	H	Qn	X	The data in the B storage flip-flops are displayed on the A Bus.
			_	((\		L <	L	The data on the B Bus are stored into the B storage flip-flops on the rising edge of CBA,
		X*		×) н	H	H	and the stored data propagate directly onto the A Bus.
			/ (V))		Output	Output	
н	L	X*	X*	, н	H	Qn	Qn	The data in the A storage flop-flops are displayed on the B Bus, and the data in the B storage flop-flops are displayed on the A.

X: Don't care

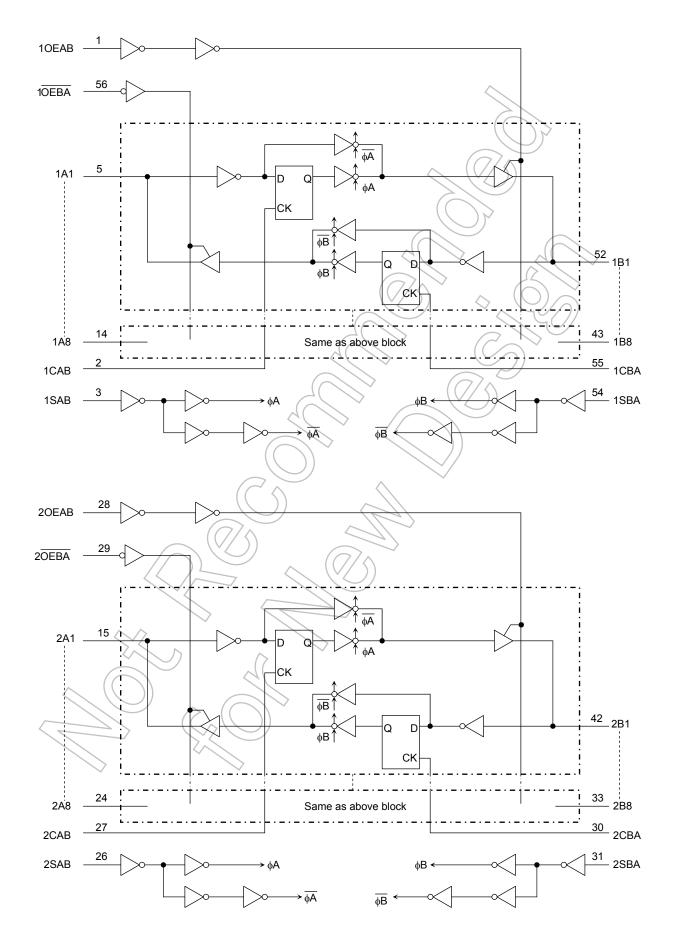
Qn: The data stored into the internal flip-flops by most recent low to high transition of the clock inputs.

Z: High impedance

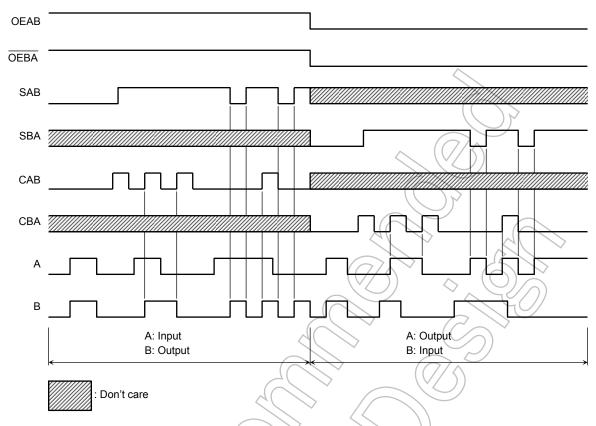
^{*:} The clocks are not internally gated with either OEAB or OEBA.

Therefore, data on the A and/or B busses may be clocked into the storage flip-flops at any time.

System Diagram



Timing Chart



Absolute Maximum Ratings (Note 1)

4	Characteristics	Symbol	Rating	Unit
Power supp	ly voltage	(Vcc))	-0.5 to 4.6	V
DC input	(OEAB, OEBA, SAB, SBA, CAB, CBA)	7/\	-0.5 to 4.6	V
voltage	(An, Bn)	VIN	-0.5 to V _{CC} + 0.5 (Note 2)	
DC output voltage	(An, Bn)	Vouт	-0.5 to V _{CC} + 0.5 (Note 3)	V
Input diode	current	I _{IK}	-50	mA
Output diod	e current	lok	±50 (Note 4)	mA
Output current		lout	±50	mA
Power dissipation		PD	400	mW
DC V _{CC} /ground current per supply pin		ICC/IGND	±100	mA
Storage tem	perature	T _{stg}	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

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Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: OFF state

Note 3: High or low state. IOUT absolute maximum rating must be observed.

Note 4: $V_{OUT} < GND, V_{OUT} > V_{CC}$

Operating Ranges (Note 1) (Note 2)

Characteristics		Symbol	Rating	Unit
Dowor sur	oply voltage	V _{CC}	1.8 to 3.6	V
rower sup	oply voltage	VCC	1.2 to 3.6 (Note 3)	V
Input	(OEAB, OEBA, SAB, SBA, CAB, CBA)	VIN	-0.3 to 3.6	
voltage	(An, Bn)		0 to V _{CC} (Note 4)	
Output voltage	(An, Bn)	V _{OUT}	0 to V _{CC} (Note 5)	V
			±24 (Note 6)	
Output current		I _{OH} /I _{OL}	±18 (Note 7)	mA
			±6 (Note 8)	
Operating temperature		T _{opr}	-40 to 85	°C
Input rise	and fall time	dt/dv	0 to 10 (Note 9)	ns/V

- Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V_{CC} or GND.
- Note 2: Floating or unused control inputs must be held high or low.
- Note 3: Data retention only
- Note 4: OFF state
- Note 5: High or low state
- Note 6: $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$
- Note 7: $V_{CC} = 2.3 \text{ to } 2.7 \text{ V}$
- Note 8: $V_{CC} = 1.8 \text{ V}$
- Note 9: $V_{IN} = 0.8$ to 2.0 V, $V_{CC} = 3.0$ V

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Electrical Characteristics

DC Characteristics (Ta = -40 to 85° C, $2.7 \text{ V} < \text{V}_{\text{CC}} \le 3.6 \text{ V}$)

Characteristics		Symbol	Test Condition		V _{CC} (V)	Min	Max	Unit	
Input voltage	H-level	V _{IH}	-	_	2.7 to 3.6	2.0	_	V	
input voitage	L-level	V _{IL}	-	_	2.7 to 3.6	_	8.0	V	
				I _{OH} = -100 μA	2.7 to 3.6	V _{CC} - 0.2	_		
	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -12 mA	//2.7	2.2	_		
				I _{OH} = -18 mA	3.0	2.4	_		
Output voltage				$I_{OH} = -24 \text{ mA}$	3.0	2.2	_	V	
	L-level			$I_{OL} = 100 \mu\text{A}$	2.7 to 3.6		0.2		
		V _{OL}	$V_{IN} = V_{IH}$ or V_{IL}	I _{OL} = 12 mA	2.7	*	0.4		
				$I_{OL} = 18 \text{ mA}$	3.0		0.4		
				I _{OL} ≠ 24 mA	3.0)+	0.55		
Input leakage current (OEAB, OEBA, SAB, CBA)	SBA, CAB,	I _{IN}	V _{IN} = 0 to 3.6 V		2.7 to 3.6	<u> </u>	±5.0	μΑ	
Bushold input minimun	n drive hold		V _{IN} = 0.8 V		3.0	75	_	•	
current		I (HOLD)	V _{IN} = 2.0 V		3.0	-75	_	μА	
Bushold input over-drive current to		li (ann)	2	(Note 1)	3.6	_	450	^	
change state		I _{I (OD)}		(Note 2)	3.6	_	-450	μА	
3-state output OFF state current		loz	V _{IN} = V _{IH} or V _{IL} V _{OUT} = V _{CC} or GND		2.7 to 3.6		±10.0	μА	
Quiescent supply current		Icc	$V_{IN} = V_{CC}$ or GND		2.7 to 3.6	_	20.0	μΑ	
Increase in I _{CC} per inp	ut	Δlcc	$V_{IH} = V_{CC} - 0.6 V$	1691	2.7 to 3.6	_	750	μΑ	

Note 1: An external driver must source at least the specified current to switch from LOW-to-HIGH.

Note 2: An external driver must sink at least the specified current to switch from HIGH-to-LOW.



DC Characteristics (Ta = -40 to 85°C, 2.3 V \leq V_{CC} \leq 2.7 V)

Characteristics		Symbol	Test Condition		V _{CC} (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	_	_	2.3 to 2.7	1.6	_	V
input voitage	L-level	V _{IL}	_	_	2.3 to 2.7	_	0.7	V
				I _{OH} = -100 μA	2.3 to 2.7	V _{CC} - 0.2		
	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	$I_{OH} = -6 \text{ mA}$	2.3	2.0		
				I _{OH} = -12 mA	2.3	1.8		
Output voltage				I _{OH} = -18 mA	2.3	1.7		V
		V _{OL}	$V_{IN} = V_{IH}$ or V_{IL}	I _{OL} = 100 μA	2.3 to 2.7	_	0.2	
	L-level			I _{OL} = 12 mA	2.3	_	0.4	
				I _{OL} = 18 mA	2.3		0.6	
Input leakage current					/	77		
(OEAB, OEBA, SAB, CBA)	SBA, CAB,	I _{IN}	$V_{IN} = 0 \text{ to } 3.6 \text{ V}$		2.3 to 2.7		±5.0	μА
Bushold input minimun	n drive hold		V _{IN} = 0.7 V	2.3	45	/ _	Δ.	
current		I (HOLD)	V _{IN} = 1.6 V		2.3	-45	_	μΑ
Bushold input over-driv	e current to		40	(Note 1)	(2.7)	_	300	Δ.
change state		I _I (OD)		(Note 2)	2.7	_	-300	μΑ
3-state output OFF state current		I _{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = V_{CC} \text{ or GND}$		2.3 to 2.7	_	±10.0	μА
Quiescent supply curre	ent	Icc	V _{IN} = V _{CC} or GND		2.3 to 2.7	_	20.0	μА

Note 1: An external driver must source at least the specified current to switch from LOW-to-HIGH.

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Note 2: An external driver must sink at least the specified current to switch from HIGH-to-LOW.



DC Characteristics (Ta = -40 to 85° C, $1.8 \text{ V} \le \text{V}_{\text{CC}} < 2.3 \text{ V})$

Characteristi	cs	Symbol Test Condition		ondition		Min	Max	Unit	
Ondi dotonotio		- ,			V _{CC} (V)				
Input voltage	H-level	V _{IH}	_	_	1.8 to 2.3	0.7 × V _{CC}	_	V	
input voitage	L-level	VIL	_	_	1.8 to 2.3		0.2 × V _{CC}	V	
	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.8	VCC - 0.2	ı		
Output voltage				$I_{OH} = -6 \text{ mA}$	71.8	1.4	_	V	
	L-level	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	1.8	_	0.2	·	
				I _{OL} = 6 mA	1.8	_	0.3		
Input leakage current	•)~				
(OEAB, OEBA, SAB, SBA, CAB, CBA)		I _{IN}	$V_{IN} = 0$ to 3.6 V		1.8		±5.0	μΑ	
Bushold input minimun	n drive hold		V _{IN} = 0.36 V		1.8	25	> —	^	
current		I _I (HOLD)	V _{IN} = 1.26 V) 1.8	25	<u> </u>	μΑ	
Bushold input over-drive current to change state			(/	(Note 1)	1.8	4	200	^	
		I _I (OD)	(Note 2)		1.8	>_	-200	μΑ	
3-state output OFF state current		I _{OZ}	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = V_{CC}$ or GND		1.8	_	±10.0	μΑ	
Quiescent supply curre	ent	I _{CC}	V _{IN} = V _{CC} or GND		1.8	_	20.0	μА	

Note 1: An external driver must source at least the specified current to switch from LOW-to-HIGH.

Note 2: An external driver must sink at least the specified current to switch from HIGH-to-LOW.

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AC Characteristics (Ta = –40 to 85°C, input: $t_r = t_f$ = 2.0 ns, C_L = 30 pF, R_L = 500 Ω) (Note 1)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
			1.8	100	_	
Maximum clock frequency	f _{max}	Figure 1, Figure 3	2.5 ± 0.2	200	_	MHz
			3.3 ± 0.3	250	_	
Propagation delay time	.		1.8	1.5	7.0	
(An, Bn-Bn, An)	t _{pLH}	Figure 1, Figure 2	2.5 ± 0.2	0.8	3.5	ns
(All, Bli-Bli, All)	t _{pHL}		3.3 ± 0.3	0.6	2.9	
Propagation delay time	t		1.8	1.5	8.8	
(CAB, CBA-Bn, An)	t _{pLH}	Figure 1, Figure 3	2.5 ± 0.2	0.8	4.4	ns
(OND, ODIV BII, MII)	фпь		3.3 ± 0.3	0.6	3.2	
Propagation delay time	t	4(>>	1.8	1(5	8.8	
(SAB, SBA-Bn, An)	t _{pLH}	Figure 1, Figure 2	2.5 ± 0.2	0.8	4.4	ns
(OAD, OBA-BII, AII)	t _{pHL}	(\langle / \rangle)	3.3 ± 0.3	0.6	3.5	
Output enable time	t _{pZL}		1.8	(1.5)	9.8	
(OEAB, OEBA -An, Bn)		Figure 1, Figure 4, Figure 5	2.5 ± 0.2	0.8	4.9	ns
(OLAB, OLBA-AII, BII)		4(>)	3.3 ± 0.3	0.6	3.8	
Output disable time	t		1.8	1.5	8.1	
(OEAB, OEBA -An, Bn)	t _{pLZ}	Figure 1, Figure 4, Figure 5	2.5 ± 0.2	0.8	4.5	ns
(OLAB, OLBA-AII, BII)	t _{pHZ}	40	3.3 ± 0.3	0.6	3.9	
	• /		1.8	4.0	_	
Minimum pulse width	t _{w (H)}	Figure 1 Figure 3	2.5 ± 0.2	1.5	_	ns
	tw (L)		3.3 ± 0.3	1.5	_	
			1.8	2.5	_	
Minimum setup time	ts	Figure 1, Figure 3	2.5 ± 0.2	1.5	_	ns
	$\langle \langle \rangle \rangle$		3.3 ± 0.3	1.5	_	
//) [< (V/S)	1.8	1.0	_	
Minimum hold time	t _h	Figure 1, Figure 3	2.5 ± 0.2	1.0	_	ns
	<		3.3 ± 0.3	1.0	_	
$\wedge \wedge$			1.8	_	0.5	
Output to output skew	tosLH	(Note 2)	2.5 ± 0.2	_	0.5	ns
	tosHL		3.3 ± 0.3	_	0.5	

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Note 1: For C_L = 50 pF, add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$

Dynamic Switching Characteristics (Ta = 25°C, input: t_r = t_f = 2.0 ns, C_L = 30 pF, R_L = 500 Ω)

Characteristics	Symbol	Test Condition			Тур.	Unit	
		V _{IH} = 1.8 V, V _{IL} = 0 V	(Note)	1.8	0.25		
Quiet output maximum dynamic V _{OL}	V _{OLP}	V _{IH} = 2.5 V, V _{IL} = 0 V	(Note)	2.5	0.6	V	
		V _{IH} = 3.3 V, V _{IL} = 0 V	(Note)	3.3	8.0		
	V _{OLV}	V _{IH} = 1.8 V, V _{IL} = 0 V	(Note)	1.8	-0.25		
Quiet output minimum dynamic V _{OI}		$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	2.5	-0.6	V	
, 3		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	3.3	-0.8		
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	1.8	1.5		
Quiet output minimum dynamic V _{OH}	V _{OHV}	V _{IH} = 2.5 V, V _{IL} = 0 V	(Note)	2.5	1.9	V	
		V _{IH} = 3.3 V, V _{IL} = 0 V	(Note)	3.3	2.2		

Note: Parameter guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Input capacitance	C _{IN}	(OEAB, OEBA, CAB, CBA, SAB, SBA)	1.8, 2.5, 3.3	6	pF
Bus I/O capacitance	C _{I/O}	An, Bn	1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C_{PD}	f _{IN} = 10 MHz (Note)	1.8, 2.5, 3.3	20	pF

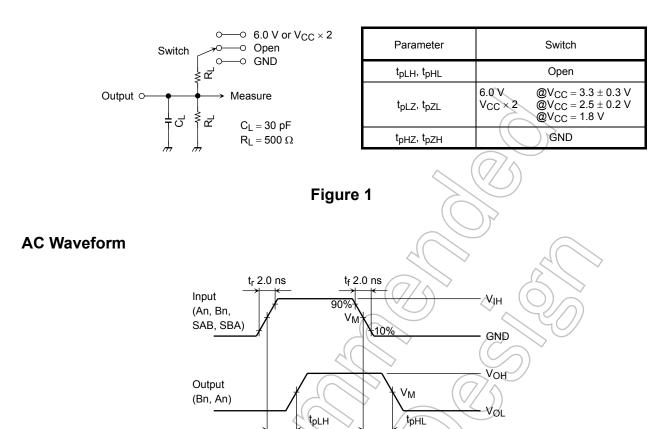
CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating Note: current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/16 (per bit)$



AC Test Circuit



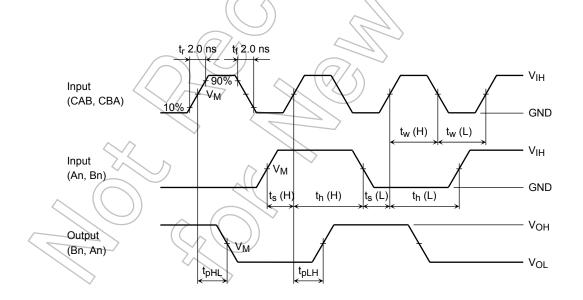


Figure 2

tpLH, tpHL

Figure 3 tpLH, tpHL, tw, ts, th

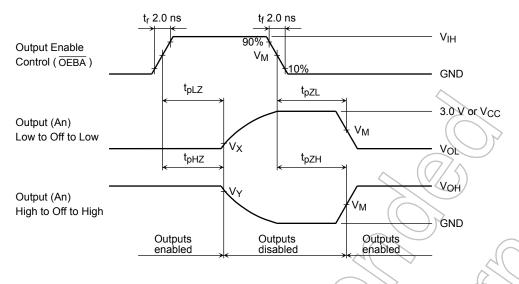


Figure 4 t_{pLZ} , t_{pHZ} , t_{pZL} , t_{pZH}

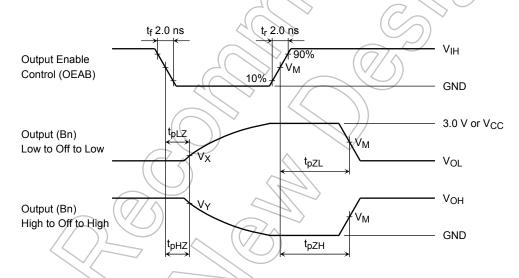


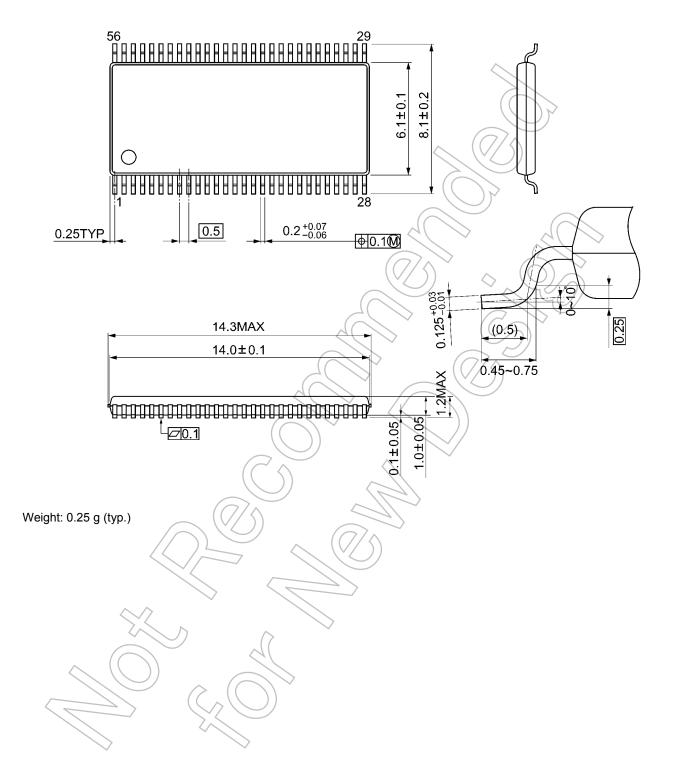
Figure 5 t_{pLZ} , t_{pHZ} , t_{pZL} , t_{pZH}

Symbol		V _{CC}	
Symbol	3.3 ± 0.3 V	$2.5\pm0.2\textrm{V}$	1.8 V
>VIH((2.7 V	V _{CC}	V _{CC}
VM	1.5 V	V _{CC} /2	V _{CC} /2
√V _X	V _{OL} + 0.3 V	V _{OL} + 0.15 V	V _{OL} + 0.15 V
VY	V _{OH} – 0.3 V	V _{OH} – 0.15 V	V _{OH} – 0.15 V

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Package Dimensions

TSSOP56-P-0061-0.50A Unit: mm



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